Se	arch N	Votes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,422	UEDA ET AL.	
Examiner	Art Unit	
Daniel Tekle	2621	

SEARCHED			
Class	Subclass	Date	Examiner
386	109	4/4/2007	DT
386	112	4/4/2007	DT
386	101	4/4/2007	DT
			·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	
4			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) and search query attached	4/4/2007	DT
Combined citation; sensormatic. as. NPL	4/4/2007	DT
Inventor search	4/12/2007	DT
James Fletcher (2621)	4/12/2007	DT
		,